Form PTO 1449 (Modified)		U.S. DEPARTMENT PATENT AND TRA	OF COMMERCE DEMARK OFFICE	ATTY DOCKET NO.		SERIAL NO. 10/594,271			
				295728US6PCT					
LIST OF	DEEE	RENCES CITED BY AF	PRICANT	APPLICANT A CONTROL OF THE CONTROL O					
LISTOF	KEFE	KENCES CITED BY AF	PLICANT	Akitoshi HIRONAKA, et al.					
				FILING DATE		GROUP			
				September 26, 2006		3641			
U.S. PATENT DOCUMENTS									
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB FILING DATE CLASS IF APPROPRIATE			
	AA				·				
	AB								
	AC								
	AD								
	AE								
	AF								
	AG								
	AH								
	Al			-					
	AJ								
	AK								
	AL								
	AM								
	AN								
FOREIGN PATENT DOCUMENTS									
	DOCUMENT DATE			COUNTRY		TRANSLATION			
		NUMBER			·	YES		NO	
	AO	JP 2971439	08/27/1999	JAPAN				×	
	AP					-			
	AQ								
	AR								
	AS								
	AT					_			
	AU								
	AV	<u> </u>		<u> </u>		<u> </u>			
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)									
	AW								
	AX								
	AY								
	ΑŻ				Add	Additional References sheet(s) attached			
Examiner	L		Date Considered						
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.									
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.									